

Notice of References Cited	Application/Control No. 10/816,093		Applicant(s)/Patent Under Reexamination WYATT, DEREK	
	Examiner Christopher P. Bruenjes		Art Unit 1772	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,016,784	05-1991	Batson, Robert E.	222/386
*	B	US-5,326,603	07-1994	Van Dyke et al.	428/35.7
*	C	US-5,827,456	10-1998	Bergner et al.	264/39
*	D	US-5,743,401	04-1998	Takahashi, Shin	206/447
*	E	US-6,558,764	05-2003	Blom et al.	428/36.92
*	F	US-2003/0015557	01-2003	D'Alessio et al.	222/566
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 08057051 A	03-1996	Japan	OKAMOTO et al.	A61M 5/31
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Machine translation of JP 08-057051 A
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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